Product data sheet

1. General description

Planar passivated high commutation triac in a SOT223 surface mounted plastic package. This "series E" triac balances the requirements of commutation performance and gate sensitivity and is intended for interfacing with low power drivers and logic ICs including microcontrollers.

2. Features and benefits

- · 3Q technology for improved noise immunity
- Direct triggering from low power drivers and logic ICs
- High commutation capability with sensitive gate
- · High immunity to false turn-on by dV/dt
- High voltage capability
- Planar passivated for voltage ruggedness and reliability
- Sensitive gate for easy logic level triggering
- Surface mountable package
- Triggering in three quadrants only

3. Applications

- · General purpose motor control
- Small loads in washing machines
- Solenoid drivers

4. Quick reference data

Table 1. Quick reference data

| Symbol | Parameter | Conditions | | Min | Тур | Max | Unit |
|------------------------|--|---|--|-----|-----|------|------|
| V_{DRM} | repetitive peak off- state voltage | | | - | - | 600 | V |
| I _{T(RMS)} | RMS on-state current | full sine wave; $T_{sp} \le 106 ^{\circ}\text{C}$; Fig. 1; Fig. 2; Fig. 3 | | - | - | 1 | А |
| Ітѕм | non-repetitive peak on- state current | full sine wave; $T_{j(init)} = 25 \text{ °C}$; $t_p = 16.7 \text{ ms}$ | | - | - | 13.7 | Α |
| | | full sine wave; $T_{j(init)} = 25 \text{ °C}$; $t_p = 20 \text{ ms}$; Fig. 4; Fig. 5 | | - | - | 12.5 | А |
| Tj | junction temperature | | | - | - | 125 | °C |
| Static characteristics | | | | | | | |
| I _{GT} | gate trigger current | $V_D = 12 \text{ V}; I_T = 0.1 \text{ A}; T2+ G+;$ $T_j = 25 \text{ °C}; Fig. 9$ | | 1 | - | 10 | mA |

| Symbol | Parameter | Conditions | Min | Тур | Max | Unit |
|-----------------------|---------------------------------------|--|-----|-----|-----|------|
| | | V _D = 12 V; I _T = 0.1 A; T2+ G-; T _j = 25 °C; <u>Fig. 9</u> | 1 | - | 10 | mA |
| | | V _D = 12 V; I _T = 0.1 A; T2- G-; T _j = 25 °C; <u>Fig. 9</u> | 1 | - | 10 | mA |
| I _H | holding current | V _D = 12 V; T _j = 25 °C; <u>Fig. 11</u> | - | - | 12 | mA |
| V _T | on-state voltage | I _T = 1.4 A; T _j = 25 °C; <u>Fig. 12</u> | - | 1.2 | 1.5 | V |
| Dynamic cha | racteristics | | | | | |
| dV _D /dt | rate of rise of off-state voltage | V_{DM} = 402 V; T_j = 125 °C; (V_{DM} = 67% of V_{DRM}); exponential waveform; gate open circuit; Fig. 14 | 600 | - | - | V/µs |
| dl _{com} /dt | rate of change of commutating current | V_D = 400 V; T_j = 125 °C; $I_{T(RMS)}$ = 1 A; dV_{com}/dt = 20 V/µs; (snubberless condition); gate open circuit | 2.5 | - | - | A/ms |
| | | V_D = 400 V; T_j = 125 °C; $I_{T(RMS)}$ = 1 A; dV_{com}/dt = 10 V/ μ s; gate open circuit | 3.5 | - | - | A/ms |

5. Pinning information

Table 2. Pinning information

| Pin | Symbol | Description | Simplified outline | Graphic symbol |
|-----|--------|-----------------|----------------------------|----------------|
| 1 | T1 | main terminal 1 | 4 | T2 |
| 2 | T2 | main terminal 2 | | G sym051 |
| 3 | G | gate | | symosi |
| 4 | T2 | main terminal 2 | ⊟1 ⊟2 ⊟3 SC-73 (SOT223) | |

6. Ordering information

Table 3. Ordering information

| Type number | Package | | | | |
|--------------|---------|--|---------|--|--|
| | Name | Description | Version | | |
| BTA201W-600E | SC-73 | plastic surface-mounted package with increased heatsink; 4 leads | SOT223 | | |

7. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

| Symbol | Parameter | Conditions | Min | Max | Unit |
|---------------------|-----------------------------------|--|-----|------|------|
| V_{DRM} | repetitive peak off-state voltage | | - | 600 | V |
| I _{T(RMS)} | RMS on-state current | full sine wave; $T_{sp} \le 106 \text{ °C}$; $Fig. 1$; $Fig. 2$; $Fig. 3$ | - | 1 | A |
| | non-repetitive peak on- | full sine wave; T _{j(init)} = 25 °C; t _p = 16.7 ms | - | 13.7 | Α |
| | state current | full sine wave; $T_{j(init)} = 25 \text{ °C}$; $t_p = 20 \text{ ms}$; Fig. 4; Fig. 5 | - | 12.5 | Α |
| l ² t | I ² t for fusing | t _p = 10 ms; SIN | - | 0.78 | A²s |
| dl _T /dt | rate of rise of on-state current | I _G = 0.2 A | - | 100 | A/µs |
| I _{GM} | peak gate current | | - | 1 | Α |
| P _{GM} | peak gate power | | - | 2 | W |
| P _{G(AV)} | average gate power | over any 20ms period | - | 0.1 | W |
| T _{stg} | storage temperature | | -40 | 150 | °C |
| Tj | junction temperature | | - | 125 | °C |

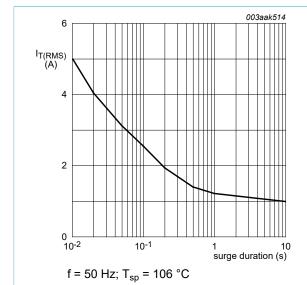


Fig. 1. RMS on-state current as a function of surge duration; maximum values

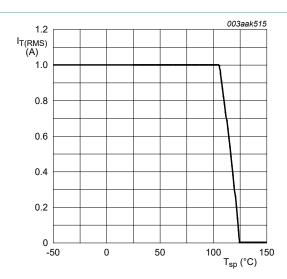


Fig. 2. RMS on-state current as a function of solder point temperature; maximum values

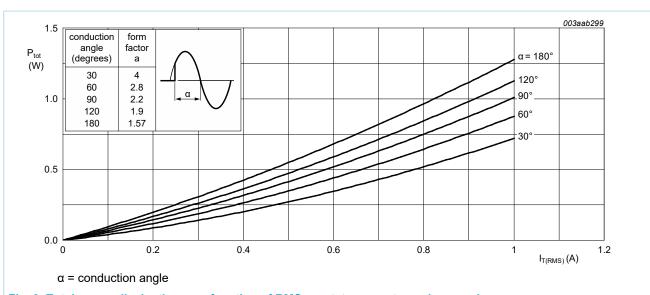


Fig. 3. Total power dissipation as a function of RMS on-state current; maximum values

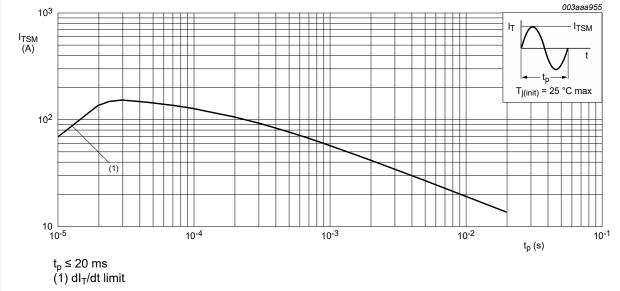


Fig. 4. Non-repetitive peak on-state current as a function of pulse width; maximum values

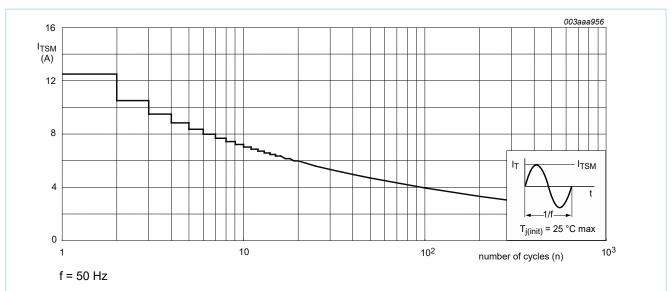
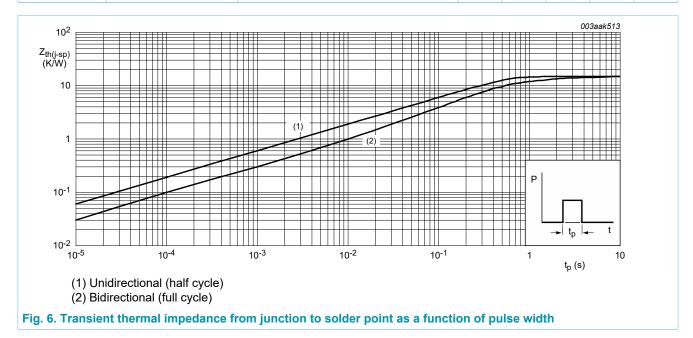


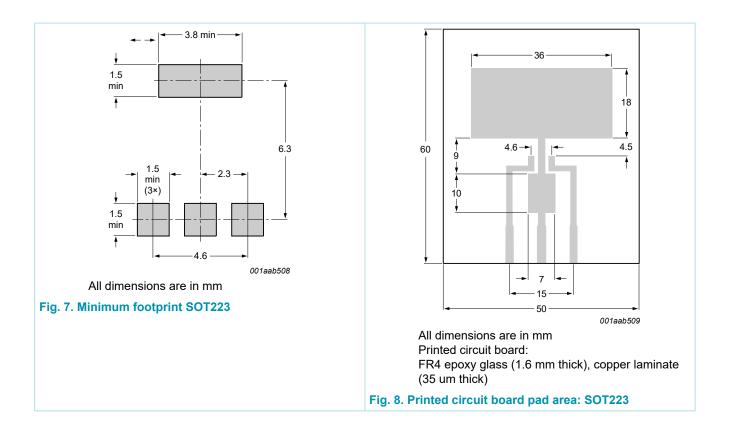
Fig. 5. Non-repetitive peak on-state current as a function of the number of sinusoidal current cycles; maximum values

8. Thermal characteristics

Table 5. Thermal characteristics

| Symbol | Parameter | Conditions | Min | Тур | Max | Unit |
|-----------------------|--|--|-----|-----|-----|------|
| R _{th(j-sp)} | thermal resistance from junction to solder point | full and half cycle; Fig. 6 | - | - | 15 | K/W |
| $R_{th(j-a)}$ | thermal resistance from junction to | in free air; printed circuit board mounted; minimum footprint; Fig. 7 | - | 156 | - | K/W |
| | ambient free air | in free air; printed circuit board mounted; pad area; Fig. 8 | - | 70 | - | K/W |





9. Characteristics

Table 6. Characteristics

| Symbol | Parameter | Conditions | Min | Тур | Max | Unit |
|-----------------------|---------------------------------------|--|-----|-----|-----|------|
| Static char | acteristics | | | | | |
| I _{GT} | gate trigger current | V _D = 12 V; I _T = 0.1 A; T2+ G+; T _j = 25 °C; <u>Fig. 9</u> | 1 | - | 10 | mA |
| | | V _D = 12 V; I _T = 0.1 A; T2+ G-; T _j = 25 °C; <u>Fig. 9</u> | 1 | - | 10 | mA |
| | | V _D = 12 V; I _T = 0.1 A; T2- G-; T _j = 25 °C; <u>Fig. 9</u> | 1 | - | 10 | mA |
| IL | latching current | V _D = 12 V; I _G = 0.1 A; T2+ G-; T _j = 25 °C; <u>Fig. 10</u> | - | - | 12 | mA |
| | | $V_D = 12 \text{ V; } I_G = 0.1 \text{ A; } T2+ G+;$ $T_j = 25 \text{ °C; } \frac{10}{\text{Fig. } 10}$ | - | - | 12 | mA |
| | | $V_D = 12 \text{ V; } I_G = 0.1 \text{ A; T2- G-;}$ $T_j = 25 \text{ °C; } \frac{\text{Fig. } 10}{\text{C}}$ | - | - | 12 | mA |
| I _H | holding current | V _D = 12 V; T _j = 25 °C; <u>Fig. 11</u> | - | - | 12 | mA |
| V _T | on-state voltage | I _T = 1.4 A; T _j = 25 °C; <u>Fig. 12</u> | - | 1.2 | 1.5 | V |
| V_{GT} | gate trigger voltage | $V_D = 12 \text{ V}; I_T = 0.1 \text{ A}; T_j = 25 \text{ °C};$ Fig. 13 | - | 0.7 | 1 | V |
| | | V _D = 400 V; I _T = 0.1 A; T _j = 125 °C; Fig. 13 | 0.2 | 0.3 | - | V |
| I _D | off-state current | V _D = 600 V; T _j = 125 °C | - | 0.1 | 0.5 | mA |
| Dynamic cl | haracteristics | | | | , | , |
| dV _D /dt | rate of rise of off-state voltage | V_{DM} = 402 V; T_j = 125 °C; $(V_{DM}$ = 67% of V_{DRM}); exponential waveform; gate open circuit; Fig. 14 | 600 | - | - | V/µs |
| dl _{com} /dt | rate of change of commutating current | V_D = 400 V; T_j = 125 °C; $I_{T(RMS)}$ = 1 A; dV_{com}/dt = 20 V/ μ s; (snubberless condition); gate open circuit | 2.5 | - | - | A/ms |
| | | V_D = 400 V; T_j = 125 °C; $I_{T(RMS)}$ = 1 A; dV_{com}/dt = 10 V/µs; gate open circuit | 3.5 | - | - | A/ms |

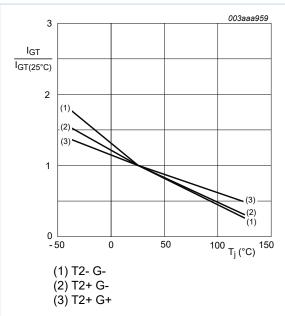


Fig. 9. Normalized gate trigger current as a function of junction temperature

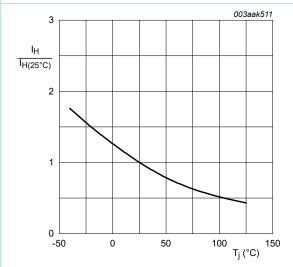


Fig. 11. Normalized holding current as a function of junction temperature

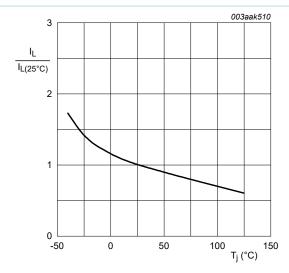
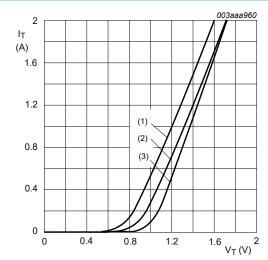


Fig. 10. Normalized latching current as a function of junction temperature



 $\begin{array}{l} \text{V}_{\text{o}} = 1.02 \text{ V}; \text{ R}_{\text{s}} = 0.358 \ \Omega \\ \text{(1)} \text{ T}_{\text{j}} = 125 \ ^{\circ}\text{C}; \text{ typical values} \\ \text{(2)} \text{ T}_{\text{j}} = 125 \ ^{\circ}\text{C}; \text{ maximum values} \\ \text{(3)} \text{ T}_{\text{j}} = 25 \ ^{\circ}\text{C}; \text{ maximum values} \end{array}$

Fig. 12. On-state current as a function of on-state voltage

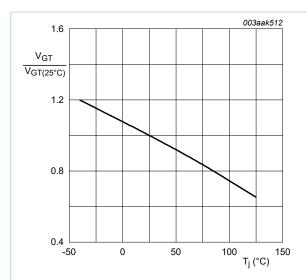


Fig. 13. Normalized gate trigger voltage as a function of junction temperature

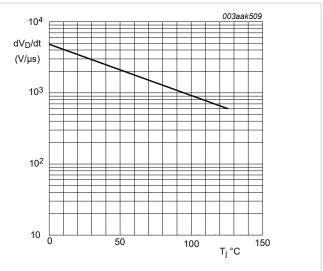
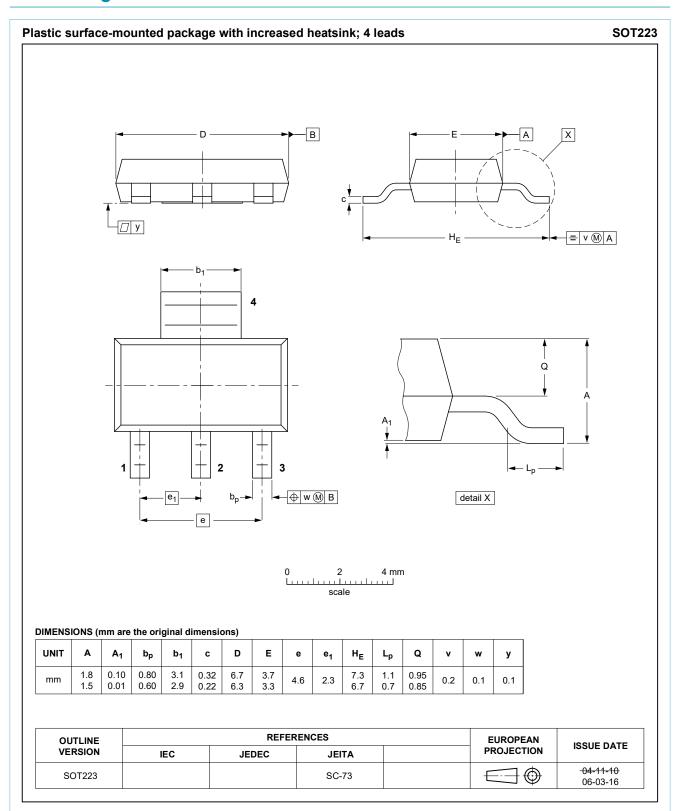


Fig. 14. Critical rate of rise of off-state voltage as a function of junction temperature; minimum values

10. Package outline



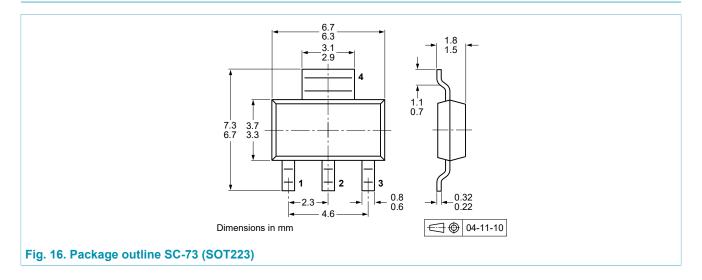
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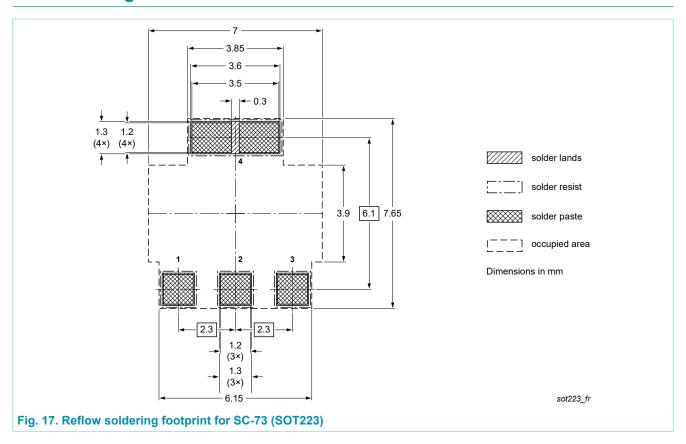
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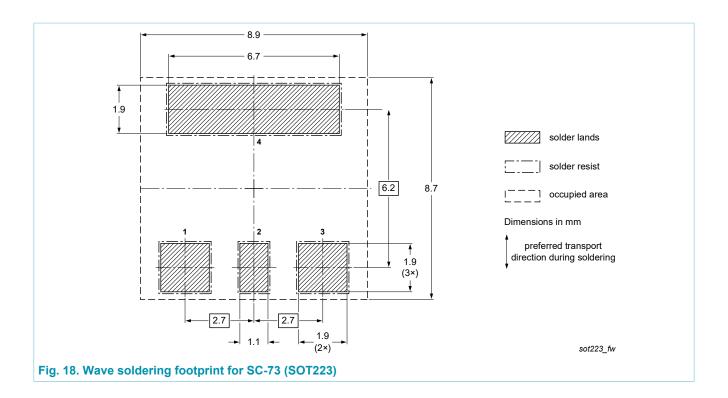
Fig. 15. Package outline SC-73 (SOT223)

11. Package outline (minimized)



12. Soldering





13. Legal information

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|--------------------------------------|--------------------|---|
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